

# Technical Specification: $\Phi$ -24 Superlattice Fabrication Tolerances

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## 1 Introduction

This document outlines the required fabrication tolerances for the realization of the  $\Phi$ -24 21-layer Fibonacci superlattice. The maintenance of the  $O(n^{1.3})$  scaling and the stability of the **Riemann Lock** are contingent upon adhering to the atomic-scale precision metrics defined herein.

## 2 Dimensional Tolerances (Epitaxial Growth)

The growth of the  $Bi_2Se_3$  and  $NbSe_2$  layers must utilize Molecular Beam Epitaxy (MBE) with real-time RHEED monitoring.

- **Layer Thickness ( $t_k$ ):** Deviation must not exceed  $\pm 0.05$  nm (approx. 1/6 of an atomic monolayer).
- **Interface Roughness ( $\sigma$ ):** RMS roughness at the  $L_{14}$  Symmetry Breaker must be  $< 0.12$  nm to prevent phononic scattering.
- **Lattice Mismatch:** Strain relaxation must be managed via the Fibonacci quasiperiodic sequence to maintain a global coherence length  $\xi > 450$  nm.

## 3 Doping & Resistivity ( $\rho$ ) Modulation

The transcendental  $\rho$  values must be achieved via precise Delta Doping. The "Simões-0.011 Law" requires the following concentration control:

$$\Delta\rho(z) = \int_0^{t_k} \psi(\text{Riemann}) \cdot dz \approx \rho_{target} \pm 10^{-5} \mu\Omega \cdot \text{cm} \quad (1)$$

## 4 The Layer 14 Critical Threshold

Layer 14 ( $L_{14}$ ) acts as the **Symmetry Breaker**. Failure to meet the following tolerances at this specific junction will result in an immediate collapse of the  $n^{1.3}$  scaling manifold:

## 5 Validation Protocol

Final device certification (**Simões-CTT Verified**) requires an  $I - V$  characteristic check at 4.2K. The emergence of the  $\alpha = 0.0765872$  resonance peak is the only acceptable proof of a successful Riemann Lock.

<b>Parameter</b>	<b>Operational Limit</b>	<b>Consequence of Violation</b>
Doping Gradient ( $\nabla\rho$ )	$\pm 0.0011\%$	Phase-Gate De-synchronization
Thermal Fluctuance	< 15 mK	Thermal Wedge Collapse
Carrier Concentration	$n_e \pm 0.02 \times 10^{18}$	Riemann Zero Misalignment

Table 1: Critical Tolerances for the  $L_{14}$  Interface.